

Development of an Enhanced Connector Testing Protocol for MV Cable Joints



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Background

- IEEE 48 (Terminations) and 404 (Joints) evaluate the connector as part of a system
- Each is a one time qualification test
- Each looks at a specific joint or termination design
- A limited number of connectors for use in a given housing (min, max, and middle for MV systems)

Background

Limitations of the “Classical” Test Procedures

- Typically test only a single connector size with a given conductor size and housing combination
- The test results are assumed to qualify a broader range of connectors and housings that are based on the same design criteria

Background

■ Other standards

- UL 486B “Wire Connectors for Use with Aluminum Conductors”
- UL 486D “Insulated Wire Connectors for Use with Underground Conductors”
- ANSI C119.1 “Insulated Low Voltage Connectors”
- ANSI C119.4 “Overhead Connectors”
- IEC 61238-1 “Connectors”

Heat Dissipation in a Joint

■ Conduction

- Housing materials
- Can help or hinder heat dissipation
- Affects connector performance
- There is a critical diameter where heat dissipation is maximized

■ Convection (air flow) – minimal impact

■ Radiation (from surface) – even less impact

■ Mass of connection (thermal capacitance)

Heat Generation in a Joint

- Load current magnitude
- Connection resistance
 - Point contact conduction
 - Oxide layer interferes
- Contact between connector and conductor surface is important
- Contact between strands within the conductor is important

Designing a Connection System

What's Important

For a joint:

- Contact between connector surface and joint body
 - Heat dissipation
 - Electrical continuity
- Elongation of the connector upon installation (push outside of conductor shield)

Designing a Connection System

For a Joint:

- Inside and Outside Diameters
- Selection of connection method (bolted, compressed, welded, etc.)
 - Retention of mechanical strength
 - Quality of electrical connection
 - Material properties of connector (hardness)
 - Surface finish/condition after installation

Designing a Connection System

For Joints:

- Barriers to fluids and gases
- Exposure to environmental conditions during installation
 - Rain, salt spray, oxidizing atmospheres
- Continuity of neutral
 - Additional heat source

Trends

- Utilities are pushing the limits of systems more and more
- Economic incentives to get all you can
- Application variety is increasing
 - New designs and concepts—Heat-shrink, Cold-shrink, premolded
 - Types—Compression, bolted, port-hole, welded, pin and socket, other
 - New Materials—EPDM, silicone, other

Trends

- Less experienced installers
- Experienced people are retiring
- Quality of training may be an issue (do you wire brush the conductor?)
- Knowledge gained by experience is not always recorded and passed along

History

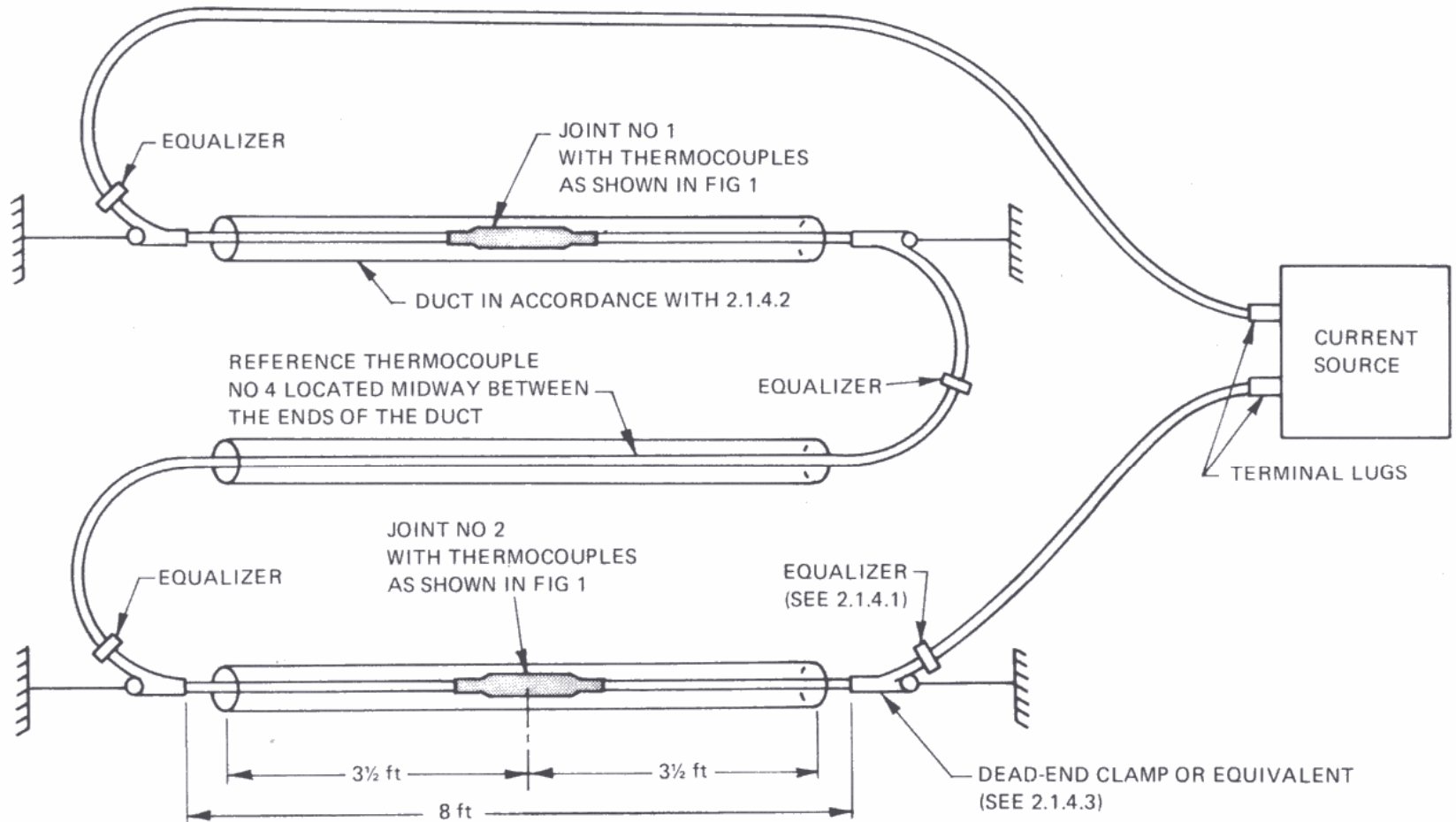
- Connector applications on insulated cables has been an issue at ICC for many years
- Earlier efforts have met mixed success
- IEEE 972 "Trial Use Standard for Connections of Insulated Aluminum Conductors" – Issued in March 1986

IEEE 972

- Covered 601 V thru 46 kV
- Connectors with Field Coverings
- Goal of Standard
 - Demonstrate with reasonable assurance that connectors meeting the standard will perform in a satisfactory manner

IEEE 972

■ Test Setup



EQUALIZERS PER 2.1.4.1 TO BE LOCATED OUTSIDE OF TENSION – LOAD SECTION

IEEE 972

Test Protocol

- Heat cycle to achieve 130 °C on reference conductor
- 100 cycle aging
- 4/0 AWG and smaller conductor
 - 3 hr ON, 3 hr OFF
- 250 kcmil and larger conductor
 - 6 hr ON, 6 hr OFF

IEEE 972

Monitored Parameters

(similar to ANSI C119.4)

■ Temperatures monitored

- On connector in joints
- On reference conductor

■ Resistance monitored

- Between equalizers on connectors
- Between equalizers on reference conductor

IEEE 972

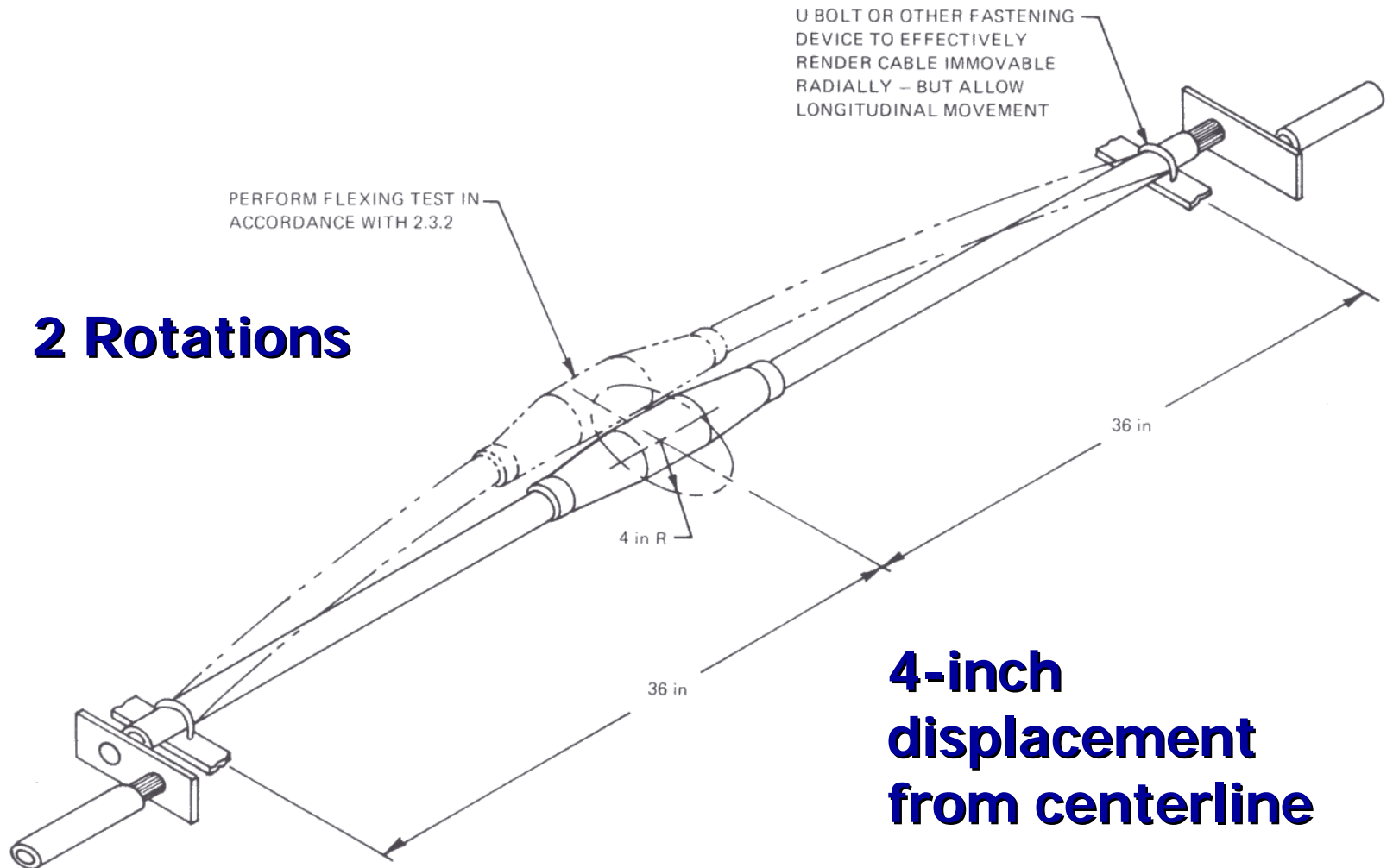
Test Protocol

- Tension applied to conductors
 - 200 lbs. minimum
 - 10% of conductor RBS (rated breaking strength)
 - Measured at ambient temperature
- Joint aged inside conduit

IEEE 972

- Flexure of Joints on selected thermal cycles
 - 28th, 56th, and 84th cycles
 - Conduits removed
 - Cable ends loosely clamped
 - Rotate around axis in loop

IEEE 972



IEEE 972

■ Evaluation criteria

- Based on ANSI C119.4
- Connector 10 °C cooler than reference conductor
- Connector resistance remains stable– variation of not more than 5% from the average of the measured values

IEEE 972

- What happened?
- Draft standard never became a full standard and was withdrawn
- Cost of doing test was high
- Setup was difficult
- All connector and housing combinations had to be tested

Where do we go from here?

- Interest within ICC seems to be in some sort of compromise or meshing of requirement between ANSI and IEC
- What's needed is data on which to make a decision
- But! What type of data? There are a multitude of approaches to the problem

Some Experimental Data

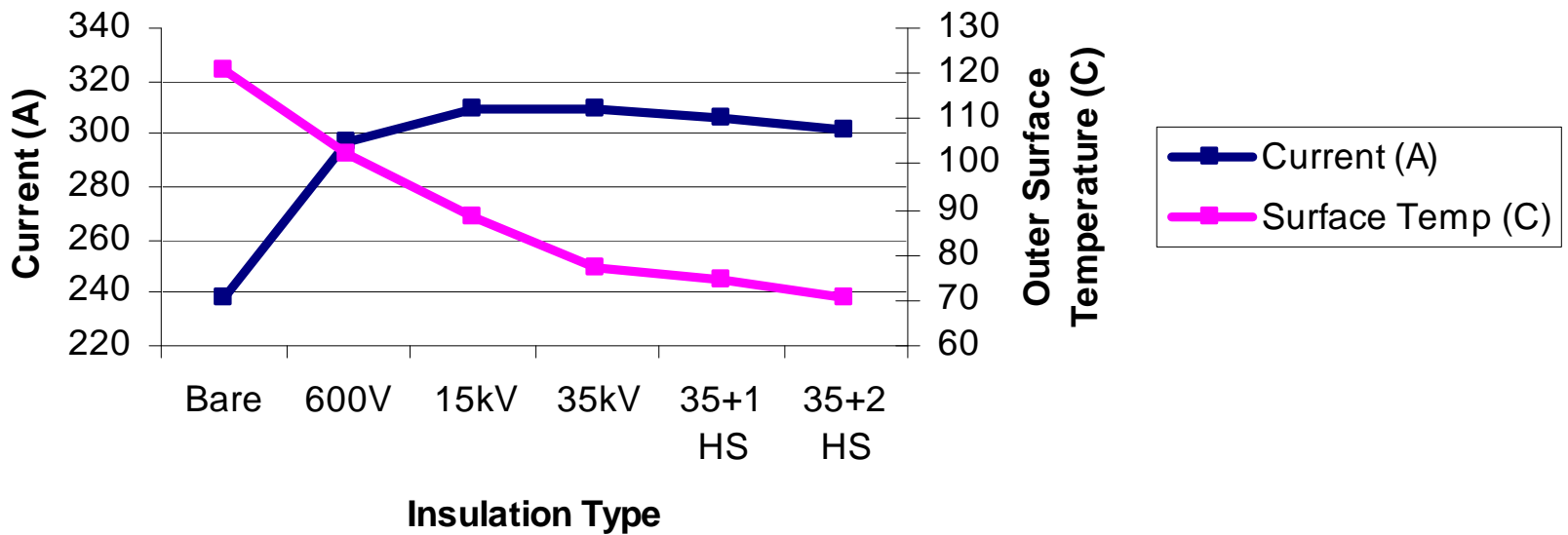
- Effect of conductor size and insulation thickness on ampacity/temperature
- 1/0 AWG Class B stranded aluminum
- Target temperature – 125 °C at conductor core
- 12 foot conductor lengths
- Various insulation thicknesses

Some Experimental Data

Cable Voltage Rating	Insulation Type	Outside Diameter (Inches)	Surface Temp (°C)	Current (A)
	Bare	0.365	120.5	238
600V	LLPE	0.520	102.2	297
15 kV	XLPE	0.845	88.2	309
35 kV	XLPE	1.171	77.1	310
35 kV	XLPE+1 HS Tube	1.359	74.3	306
35 kV	XLPE+2 HS Tubes	1.504	70.7	301

Some Experimental Data

Current for 125C Core Conductor Temperature



Some Experimental Data

- Results show that changing the insulation thickness will change the heat dissipation from the connector or cable
- Adding insulation can increase the ability to dissipate heat
- A peak in heat dissipation occurs at a particular insulation thickness, called the critical radius for each conductor diameter

What Happens When:

You test a bare connector on an insulated conductor?

Using ANSI C119.4 Procedures:

- 1/0 AWG, Class B stranded bare conductor
- Industry accepted connector for 1/0 AWG conductor

What Happens When:

Cond. Insulation	Conn. Insul.	Current (A)	Cond. Temp (°C)	Result
Bare	Bare	240	125	ANSI C119 PASS
15kV (175 mils)	Bare	290	125	ANSI C119 FAIL

What Happens When:

- Failure early in test sequence
- Temperature exceeded reference conductor
- Resistance increased steadily

Why?

- Connector temperature too high
- Creep in metal becomes a factor

What's Needed for a Meaningful Test Program

- Account for difference in heat transfer between insulated and bare components
- Evaluation of all connector/cable/cable accessory combinations is not practical
- Some assurance of extension to other components produced based on use of the same design principles

Test Protocol Development

- Use the information gained on the effect on insulation addition on temperature and effect of temperature on the connector
- Aluminum is the important case
 - Effect of creep with temperature
 - Sets a maximum limit for connector temperature

Test Protocol Development

■ Common factors

- Combination of bare and insulated conductors
- Addition of short-circuit application
- Start with a common connector known to meet ANSI C119.4
- 1/0 AWG, Class B, $\frac{3}{4}$ Hard, strand filled conductor

Test Protocol Development

- Vary the quality of the connector installation
 - Properly installed—3 compressions/side
 - Improperly installed—2 compressions/side
- Distinguish a “good” versus a “marginal” connector installation

Test Protocol Development

■ Common factors

- 4 properly installed and 4 improperly insulated connectors in each test loop
- 6 Short circuits applied at 100 cycles
- Raised conductor temperature to between 250 and 270 °C, cool to ambient between shots
- 60 cycle \pm 20 cycles/short circuit

■ Push the envelop slightly

■ 4 possible protocols considered

Test Protocol Development

ABBREVIATIONS:

CR = critical radius

Amb = Ambient

■ 4 Protocol Combinations Tried

Protocol	Ref. Cond.	Loop Cond.	Conn.	Ref. Temp.	Cycles
1	Bare	Bare	Bare	Amb+ 100°C	200
2A	Insulated @ CR	Insulated @ CR	Bare	Amb+ 100°C	200
2B	Insulated	Bare	Bare	Amb+ 100°C	200
3	Bare	Bare	Bare	140°C	300

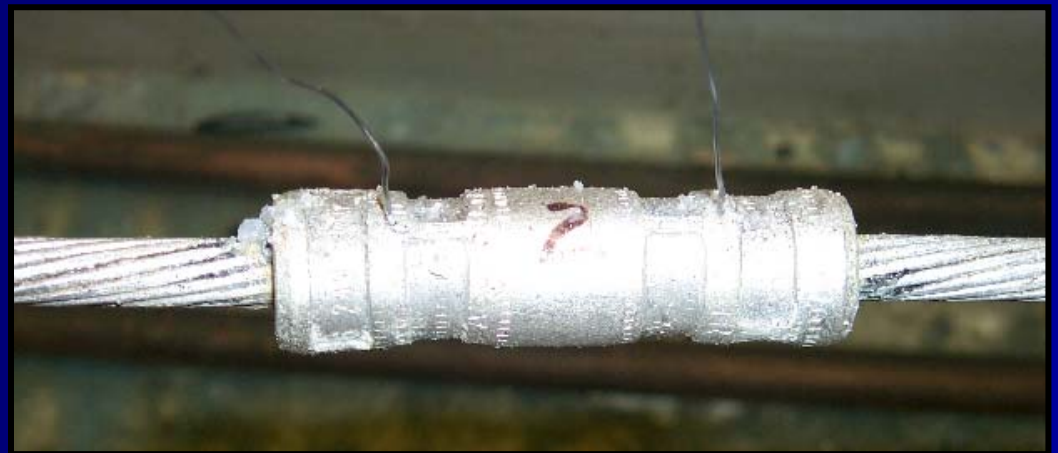
Connector Installation



Properly
Installed



Improperly
Installed



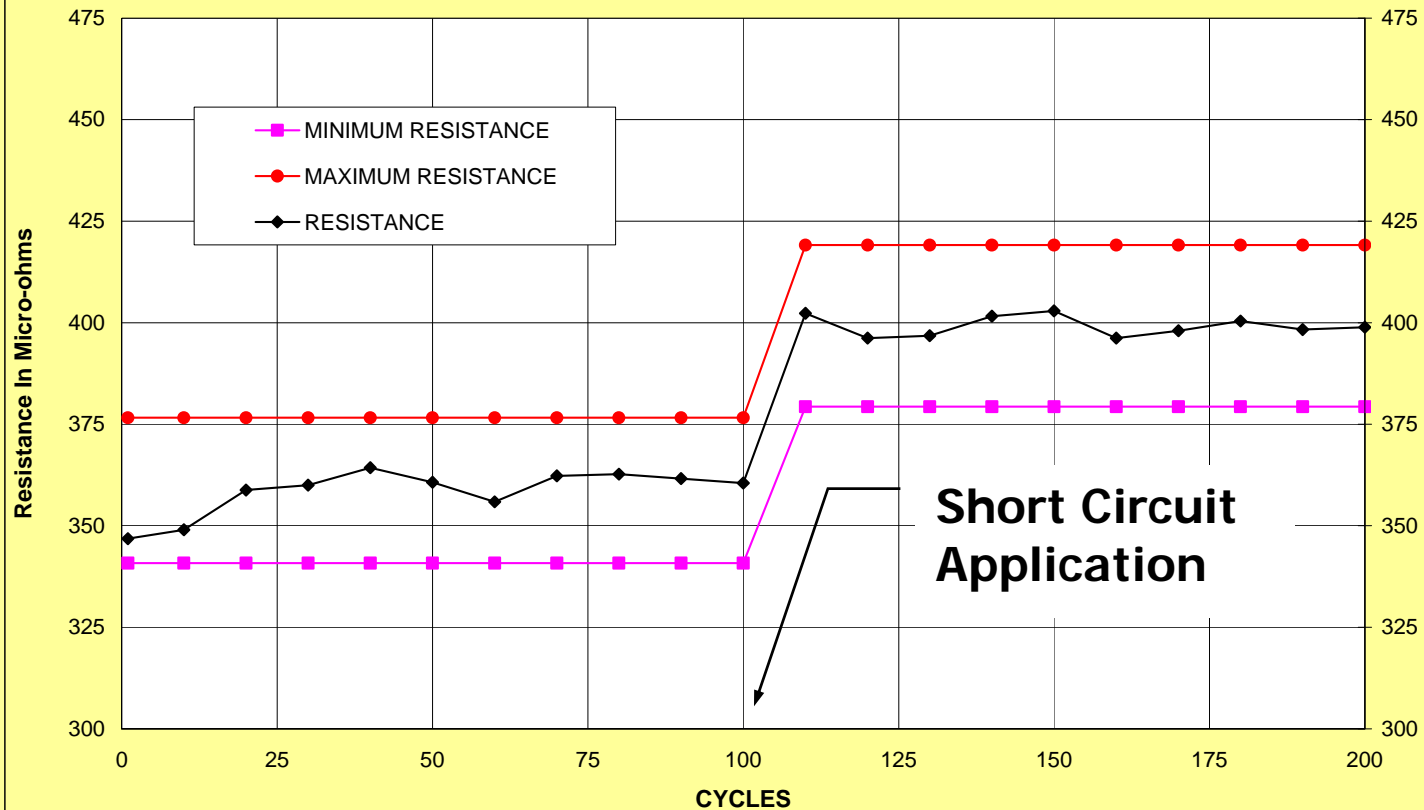
Test Method

ANSI C119.4 Current Cycle Submersion Test



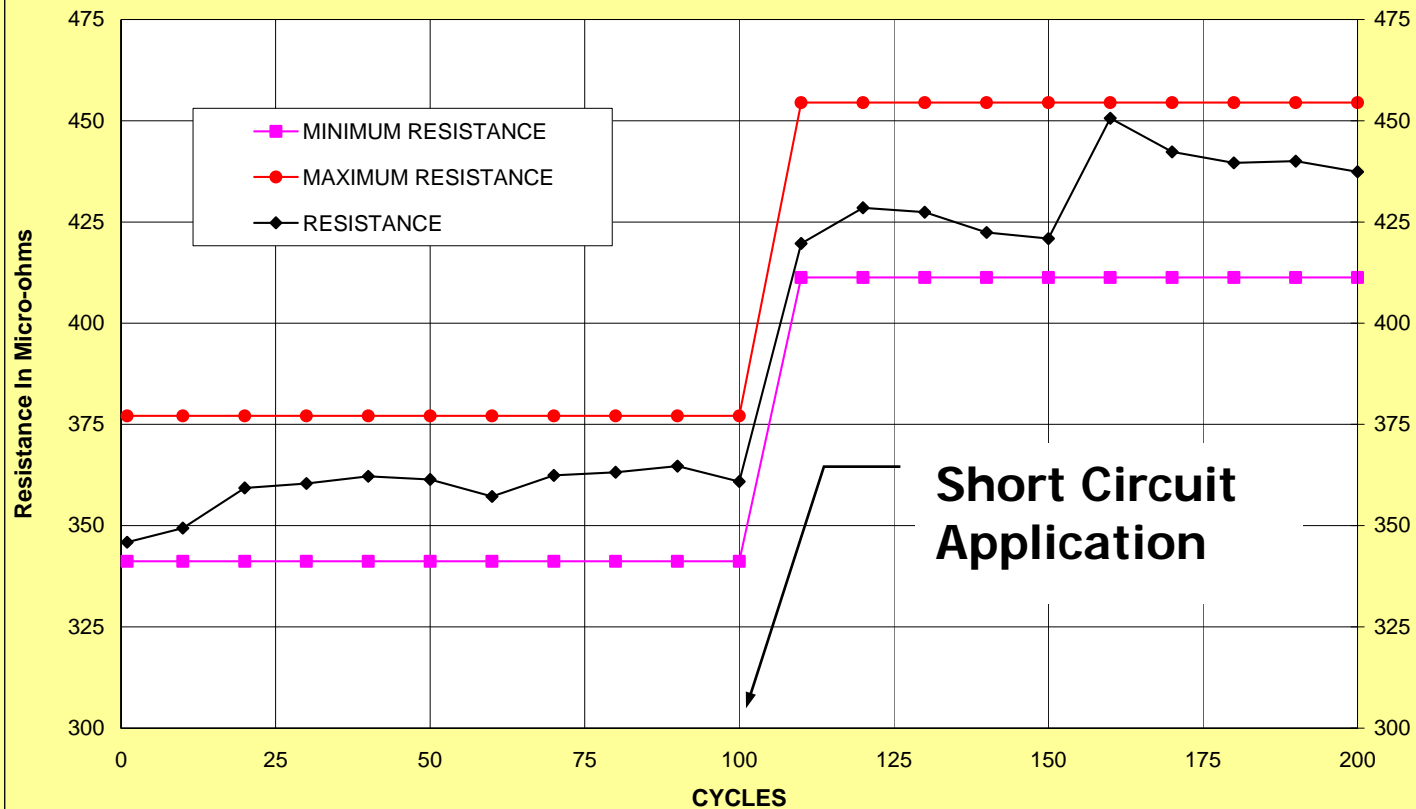
Typical Test Results

NEETRAC PROJECT # 99-425 1/0 AWG MV CONNECTOR EVALUATION
CONNECTOR INCORRECTLY INSTALLED
SHORT CIRCUIT AT CYCLE 100
Splice Connector #1 Resistance Stability



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Test Protocol Development

ABBREVIATIONS:

ICI = Incorrectly installed

CI = Correctly installed

■ Results

Proto-col	Ref. Cond.	Loop Cond.	Conn.	Results
1	Bare	Bare	Bare	PASS
2A	Insul. @ CR	Insul. @ CR	Bare	Equalizer failures
2B	Insulated	Bare	Bare	ICI failures at 22 cycles CI failures after short circuit
3	Bare	Bare	Bare	Results depend on evaluation criteria—See following Table

Test Protocol Development

- Results of Protocol 3

Connector	ANSI Temp. Stability	ANSI Resis. Stability	IEC Resis. Stability
Correct 1	PASS	FAIL	FAIL
Correct 2	PASS	PASS	PASS
Correct 3	PASS	PASS	PASS
Correct 4	PASS	PASS	PASS
Incorrect 1	PASS	FAIL	FAIL
Incorrect 2	FAIL	FAIL	FAIL
Incorrect 3	FAIL	FAIL	FAIL
Incorrect 4	PASS	PASS	FAIL

Recommendations

- Use ANSI C119.4 CCST procedures
- Apply 6 short circuits at 100 cycles
- Use IEC 61238-1, 250 - 270 °C on Reference Conductor, cool between shots
- Run 300 cycles (instead of 100 cycles)

Recommendations

- Don't use ambient + 100 °C on reference conductor
- Use 140 °C reference conductor temperature
- Use ANSI C119.4 temperature and resistance stability analysis
- Use IEC 61238-1 resistance analysis

Recommendations

- Other test protocols are possible
- Consider results of testing
- Consider the physical aspects of what leads to connector deterioration
- Recognize the limitations of the materials involved in setting test parameters